TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS)

TPCT4204

TENTATIVE

Lithium Ion Secondary Battery Applications

- Lead(Pb)-Free
- Small footprint due to small and thin package
- Low source-source ON resistance: RSS (ON) = (22)m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = (25) S$ (typ.)
- Low leakage current: $I_{SSS} = 10 \mu A \text{ (max) (V}_{SS} = 30 \text{ V)}$
- Enhancement-model: $V_{th} = 0.5 \text{to} 1.2 \text{ V}(V_{SS} = 10 \text{ V}, I_S = 200 \,\mu\text{ A})$
- Common drain

Maximum Ratings (Ta = 25°C)

Characteristics			Symbol	Rating	Unit	
Source-source voltage			V_{SSS}	30	V	
Gate-source voltage			V _{GSS}	±12	V	
Source current	DC	(Note 1)	IS	6	Α	
	Pulse	(Note 1)	I _{SP}	24		
Power dissipation (t = 10s) (Note 2a,3)			P_{D}	1.7	W	
Power dissipation (t= 10s) (Note 2b,3)			P_{D}	0.51	W	
Single pulse avalanche energy (Note 4)			E _{AS}	TBD	mJ	
Avalanche current			I _{AR}	6	Α	
Repetitive avalanche energy (Note 2a, 5)			E _{AR}	0.17	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55to150	°C	

Note: For (Note 1), (Note 2), (Note 3), (Note 4) and (Note 5), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.

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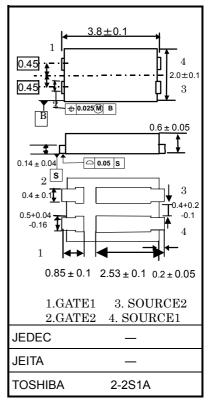
【Handling Precaution for Power MOSFET in use of Protection Circuit for Battery Pack 】

Flame-retardant resins of UL94-V0 flammability class are used in packages, however, they are not noncombustible.

Use a unit, for example PTC Thermistor, which can shut off the power supply if a short-circuit occurs.

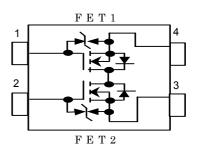
If the power supply is not shut off on the occurring short-circuit, a large short-circuit current will flow continuously, which may cause the device to catch fire or smoke.

Unit: mm



Weight: 0.012 g (typ.)

Circuit Configuration

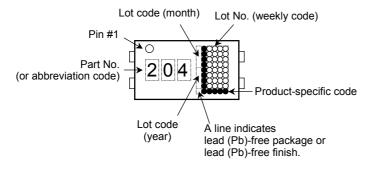


Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a,3)	R _{th (ch-a)}	76	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b,3)	R _{th (ch-a)}	244	°C/W

TENTATIVE

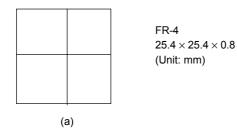
Marking (Note 6)



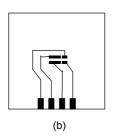
Note 1: Ensure that the channel temperature does not exceed 150 .

Note 2:

(a) Device mounted on a glass-epoxy board



(b) Device mounted on a glass-epoxy board



FR-4 $25.4 \times 25.4 \times 0.8$ (Unit: mm)

Note 3: The power dissipation and thermal resistance values are shown for both FETs.

Note 4: $V_{DD} = 24 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = mH, $R_G = 25 \Omega$, $I_{AR} = 6 \text{ A}$

Note 5: Repetitive rating: pulse width limited by max channel temperature.

Note 6: on lower left of the marking indicates Pin 1.

Electrical Characteristics (Ta = 25°C)

TENTATIVE

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{SS} = 0 \text{ V}$ (Note 8)	_		±10	μΑ
Source cut-OFF current		I _{SSS}	$V_{SS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ (Note 8)	_	_	10	μΑ
Drain-source breakdown voltage		V (BR) SSS	$I_S = 10 \text{ mA}, V_{GS} = 0 \text{ V}$ (Note 8)	30	_		V
		V _(BR) SSX	$I_S = 10 \text{ mA}, V_{GS} = -12 \text{ V}$ (Note 8)	15			
Gate threshold voltage		V_{th}	$V_{SS} = 10 \text{ V}, I_S = 200 \mu\text{A}$ (Note 8)	0.5		1.2	V
Drain-source ON resistance		R _{SS} (ON)	$V_{GS} = 2.5 \text{ V}, I_S = 3 \text{ A}$ (Note 7)	(24)	(33)	(44)	mΩ
			$V_{GS} = 4.0 \text{ V}, I_S = 3 \text{ A}$ (Note 7)	(18.5)	(23)	(29.5)	
			$V_{GS} = 4.5 \text{ V}, I_S = 3 \text{ A}$ (Note 7)	(17.5)	(22)	(28)	
Forward transfer admittance		Y _{fs}	$V_{SS} = 10 \text{ V}, I_S = 3 \text{ A}$ (Note 8)	(12.5)	(25)	_	S
Input capacitance		C _{iss}	\\ 40\\\\\ 0\\\ f 4MII-	_	(1990)	_	pF
Reverse transfer capacitance		C _{rss}	$V_{SS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ (Note 8)	_	(150)	_	
Output capacitance		Coss	(Note o)	_	(210)		
Switching time	Rise time	t _r	5 V I _S = 3 A V _{OUT}	_	TBD		ns
	Turn-on time	t _{on}	VGS 0 V V V V V V V V V V V V V V V V V V	_	TBD		
	Fall time	t _f	V _{SS} ≈ 15 V	_	TBD		
	Turn-off time	t _{off}	Duty ≦ 1%, t _w = 10 μs (Note 8)	_	TBD	_	
Total gate charge		Qg	$V_{SS} \simeq 24 \text{ V}, V_{GS} = 5 \text{ V}, I_S = 6 \text{ A}$	_	TBD	_	nC
Gate-source charge1		Q _{gs1}	(Note 8)	_	TBD	_	IIC
Diode (source-source) forward voltage		V _{SSF}	$I_{SR} = 6 \text{ A}, V_{GS} = 0 \text{ V}$ (Note 9)			-1.2	V

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